


<b>Search Notes</b>  	<b>Application/Control No.</b>  10596589	<b>Applicant(s)/Patent Under Reexamination</b>  MARUYAMA ET AL.
	<b>Examiner</b>  Elizabeth Burkhart	<b>Art Unit</b>  1715

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
STIC search	7/2/2009	EB
eDAN inventor search & EAST with key terms (See history) & NPL search-Google Scholar with key terms	10/9/2009	EB
Updated Search (see history), NPL Search-Google Scholar with key terms	4/7/2010	EB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
427	255.28	4/7/2010	EB

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